

# BLL6G1214L-250

LDMOS L-band radar power transistor

Rev. 1 — 16 February 2012

Preliminary data sheet

## 1. Product profile

### 1.1 General description

250 W LDMOS power transistor intended for L-band radar applications in the 1.2 GHz to 1.4 GHz range.

**Table 1. Test information**

Typical RF performance at  $T_{case} = 25\text{ °C}$ ;  $t_p = 1\text{ ms}$ ;  $\delta = 10\%$ ;  $I_{Dq} = 150\text{ mA}$ ; in a class-AB production test circuit.

Test signal	f (GHz)	V <sub>DS</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	$\eta_D$ (%)	t <sub>r</sub> (ns)	t <sub>f</sub> (ns)
pulsed RF	1.2 to 1.4	36	250	15	45	15	5

### 1.2 Features and benefits

- Typical pulsed RF performance at a frequency of 1.2 GHz to 1.4 GHz, a supply voltage of 36 V, an  $I_{Dq}$  of 150 mA, a  $t_p$  of 1 ms with  $\delta$  of 10 %:
  - ◆ Output power = 250 W
  - ◆ Power gain = 15 dB
  - ◆ Efficiency = 45 %
- Easy power control
- Integrated ESD protection
- High flexibility with respect to pulse formats
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (1.2 GHz to 1.4 GHz)
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

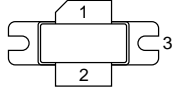
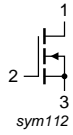
### 1.3 Applications

- L-band power amplifiers for radar applications in the 1.2 GHz to 1.4 GHz frequency range



## 2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	drain		
2	gate		
3	source		

[1] Connected to flange

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BLL6G1214L-250	-	flanged LDMOST ceramic package; 2 mounting holes; 2 leads	SOT502A

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	89	V
$V_{GS}$	gate-source voltage		-0.5	+11	V
$I_D$	drain current		-	59	A
$T_{stg}$	storage temperature		-65	+150	°C
$T_j$	junction temperature		-	200	°C

## 5. Thermal characteristics

**Table 5. Thermal characteristics**

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-case)}$	thermal resistance from junction to case	$T_{case} = 85\text{ }^{\circ}\text{C}; P_L = 250\text{ W}$	0.244	K/W
$Z_{th(j-c)}$	transient thermal impedance from junction to case	$T_{case} = 85\text{ }^{\circ}\text{C}; P_L = 250\text{ W}$	[1]	
		$t_p = 1000\text{ }\mu\text{s}; \delta = 10\text{ }\%$	0.124	K/W
		$t_p = 100\text{ }\mu\text{s}; \delta = 10\text{ }\%$	0.059	K/W
		$t_p = 200\text{ }\mu\text{s}; \delta = 10\text{ }\%$	0.077	K/W
		$t_p = 300\text{ }\mu\text{s}; \delta = 10\text{ }\%$	0.088	K/W
		$t_p = 100\text{ }\mu\text{s}; \delta = 20\text{ }\%$	0.078	K/W

[1]  $Z_{th(j-c)}$  values are calculated from results obtained with ANSYS simulations and confirmed with IR measurements during development stage. During production: guaranteed by design.

## 6. Characteristics

**Table 6. DC Characteristics**

$T_j = 25\text{ }^{\circ}\text{C}$

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0\text{ V}; I_D = 3.36\text{ mA}$	91.5	-	105.5	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 20\text{ V}; I_D = 336\text{ mA}$	1.4	1.9	2.4	V
$I_{DSS}$	drain leakage current	$V_{GS} = 0\text{ V}; V_{DS} = 42\text{ V}$	-	-	4.2	$\mu\text{A}$
$I_{DSX}$	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75\text{ V}; V_{DS} = 10\text{ V}$	50	59	-	A
$I_{GSS}$	gate leakage current	$V_{GS} = 11\text{ V}; V_{DS} = 0\text{ V}$	-	-	420	nA
$g_{fs}$	forward transconductance	$V_{DS} = 10\text{ V}; I_D = 336\text{ mA}$	51.6	-	-	mS
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75\text{ V}; I_D = 11.7\text{ A}$	-	-	127	$\text{m}\Omega$
$C_{iss}$	input capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 40\text{ V}; f = 1\text{ MHz}$	-	285	-	pF
$C_{oss}$	output capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 40\text{ V}; f = 1\text{ MHz}$	-	90	-	pF
$C_{rSS}$	reverse transfer capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 40\text{ V}; f = 1\text{ MHz}$	-	3	-	pF

**Table 7. RF characteristics**

Test signal: pulsed RF;  $t_p = 1\text{ ms}; \delta = 10\text{ }\%$ ; RF performance at  $V_{DS} = 36\text{ V}; I_{Dq} = 150\text{ mA}; T_{case} = 25\text{ }^{\circ}\text{C}$ ; unless otherwise specified, in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{DS}$	drain-source voltage		-	-	36	V
$I_{Dq}$	quiescent drain current	No RF applied	-	150	-	mA
$P_L$	output power		250	-	-	W
$f_{range}$	frequency range		1200	-	1400	MHz
$t_p$	pulse duration	$\delta = 10\text{ }\%$	-	-	1	ms
		$\delta = 20\text{ }\%$	-	-	100	$\mu\text{s}$

**Table 7. RF characteristics ...continued**

Test signal: pulsed RF;  $t_p = 1 \text{ ms}$ ;  $\delta = 10 \%$ ; RF performance at  $V_{DS} = 36 \text{ V}$ ;  $I_{Dq} = 150 \text{ mA}$ ;  $T_{case} = 25 \text{ }^\circ\text{C}$ ; unless otherwise specified, in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$\eta_D$	drain efficiency		42	45	-	%
$t_r$	rise time	$P_L = 250 \text{ W}$	[1]	-	-	200 ns
$t_f$	fall time	$P_L = 250 \text{ W}$	[1]	-	-	200 ns
$G_p$	power gain		13	15	-	dB
$P_{\text{droop(pulse)}}$	pulse droop power		-	-	0.6	dB
$RL_{in}$	input return loss		-	-	-8	dB

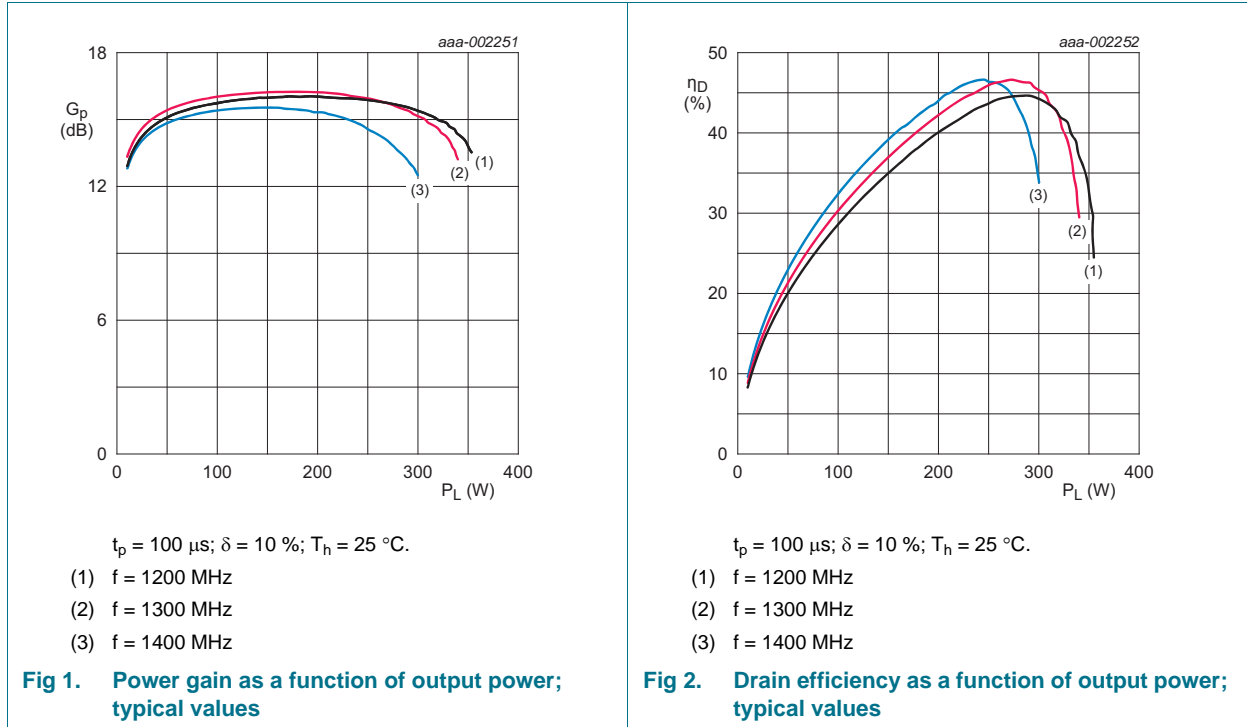
[1] The rise and fall time of the input circuit will be 5 ns maximum.

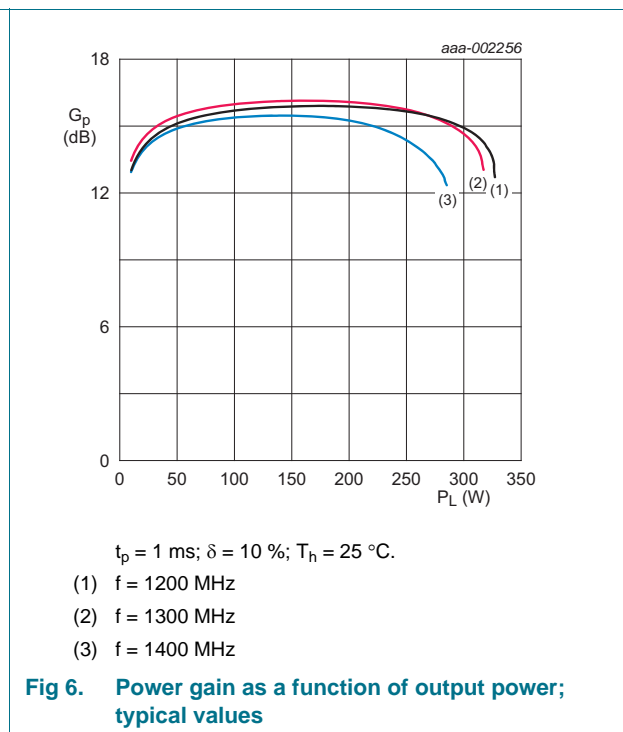
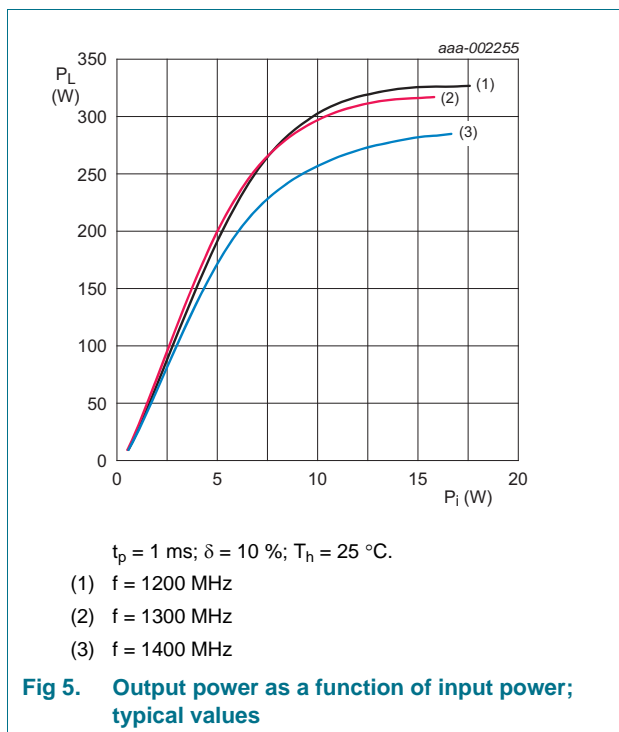
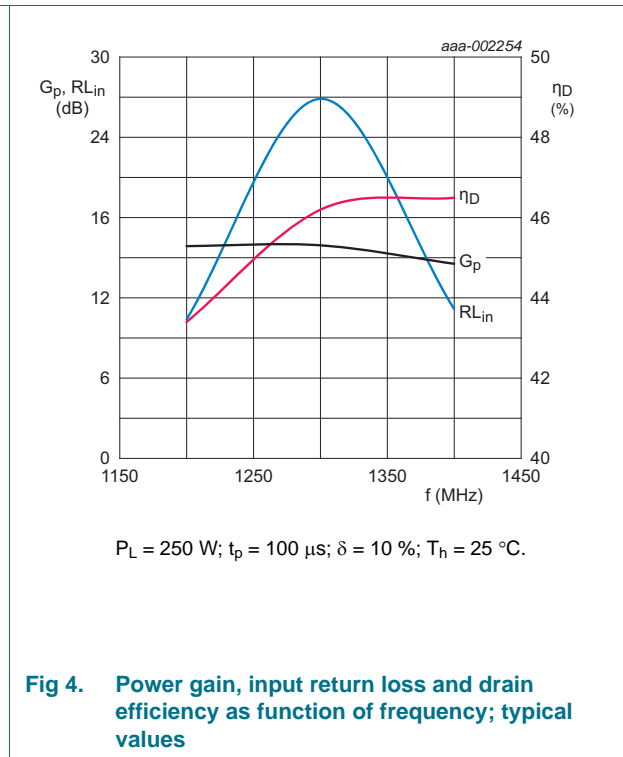
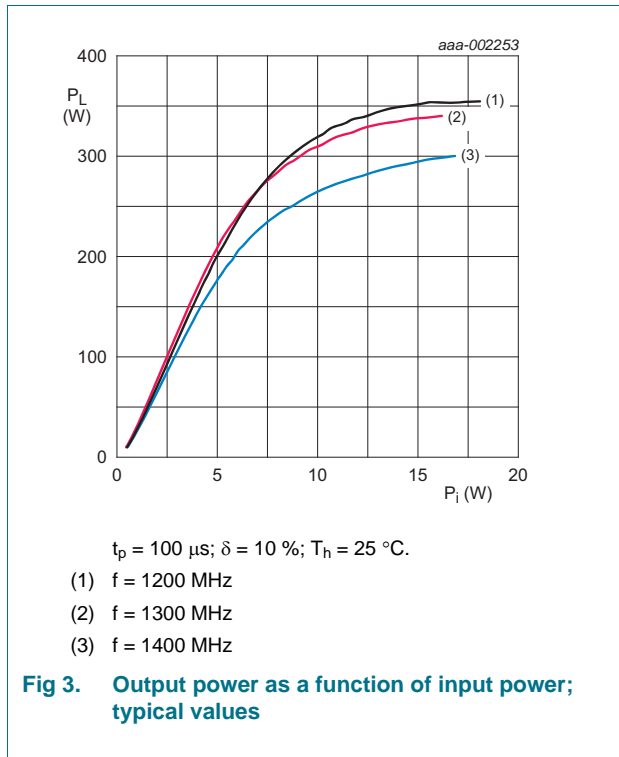
### 6.1 Ruggedness in class-AB operation

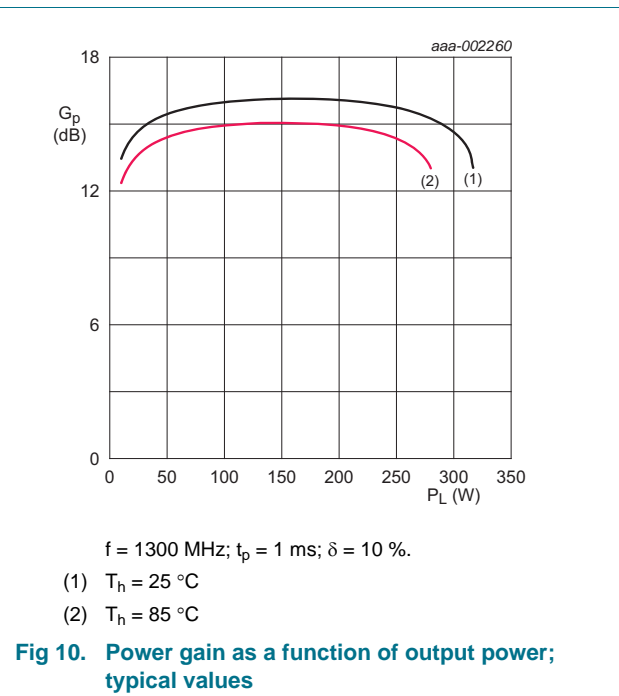
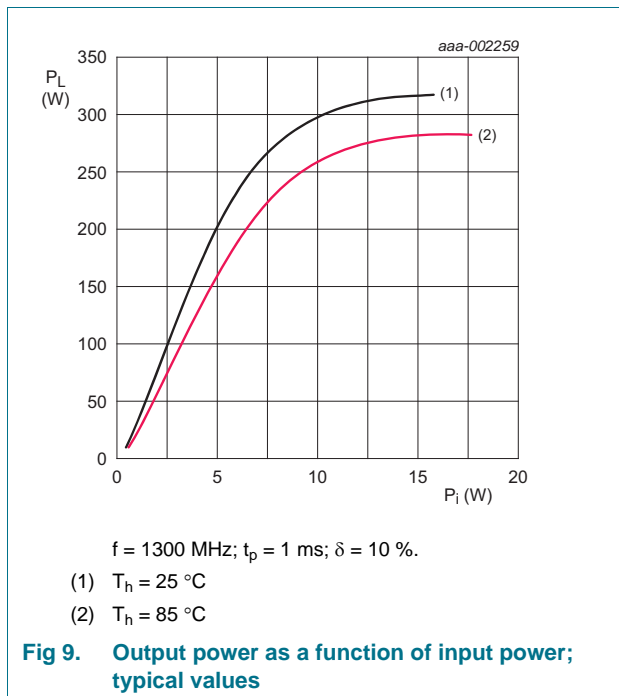
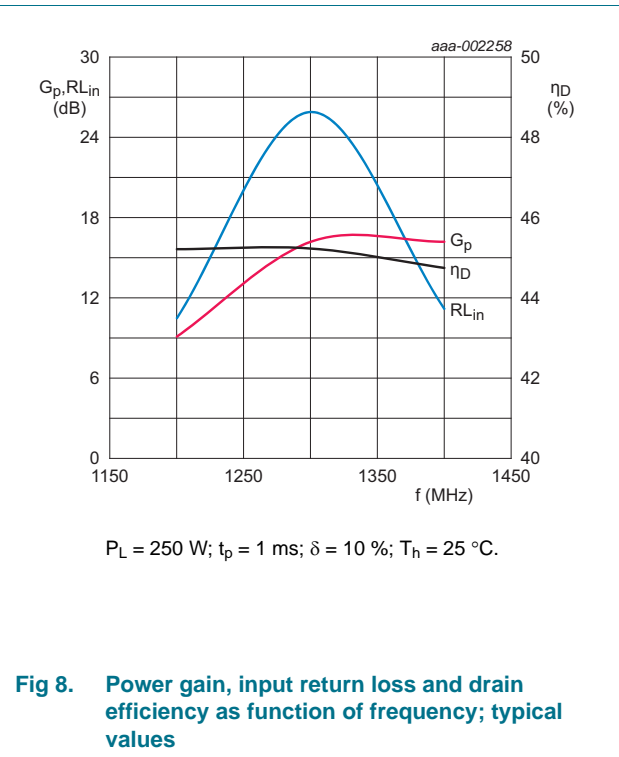
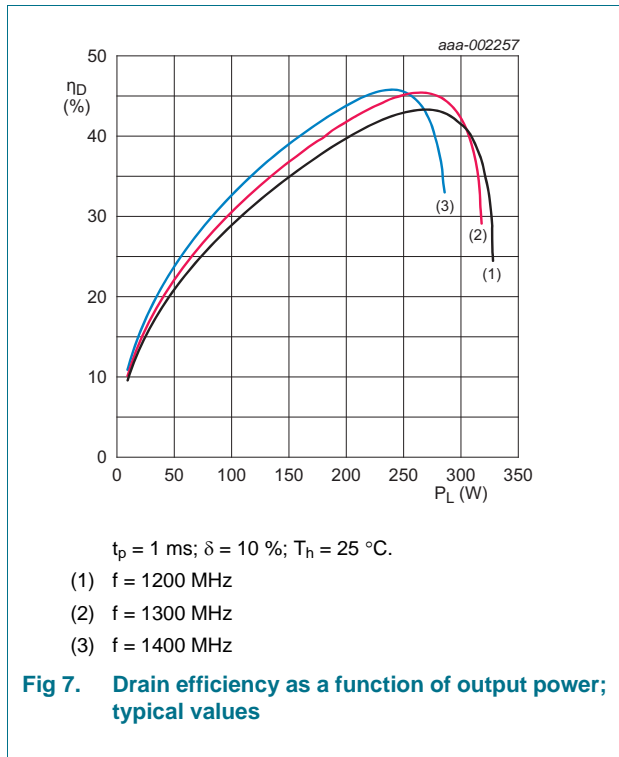
The BLL6G1214L-250 is capable of withstanding a load mismatch corresponding to  $VSWR = 10 : 1$  through all phases under the following conditions:  $V_{DS} = 36 \text{ V}$ ;  $I_{Dq} = 150 \text{ mA}$ ;  $P_L = 250 \text{ W}$ ;  $t_p = 1 \text{ ms}$ ;  $\delta = 10 \%$ .

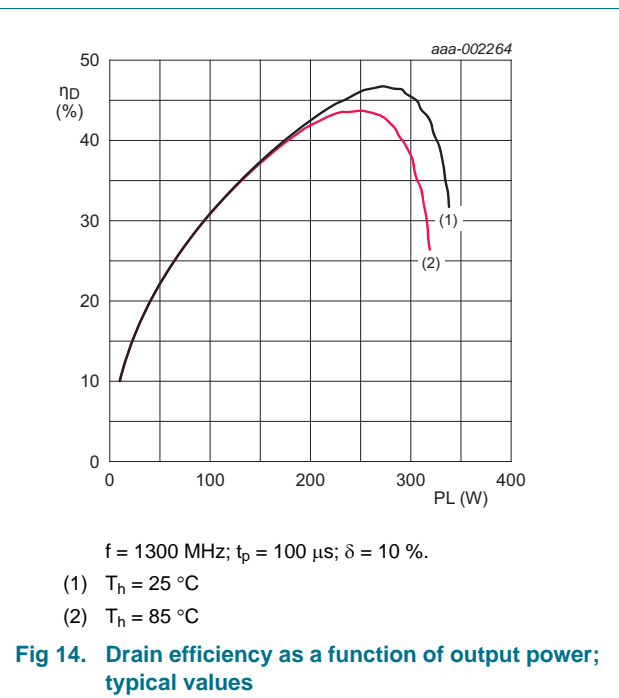
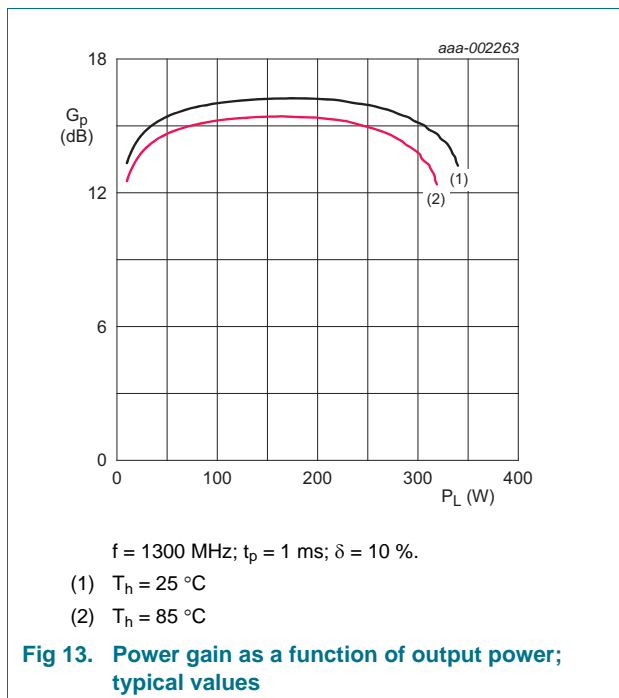
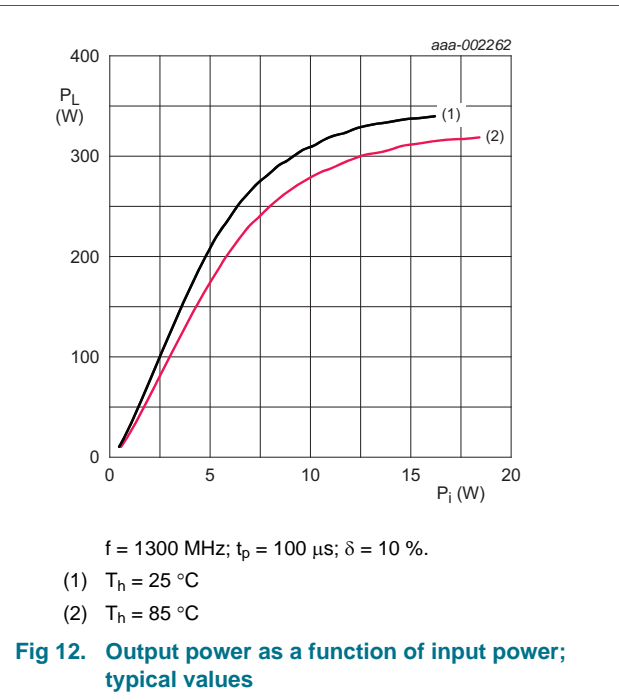
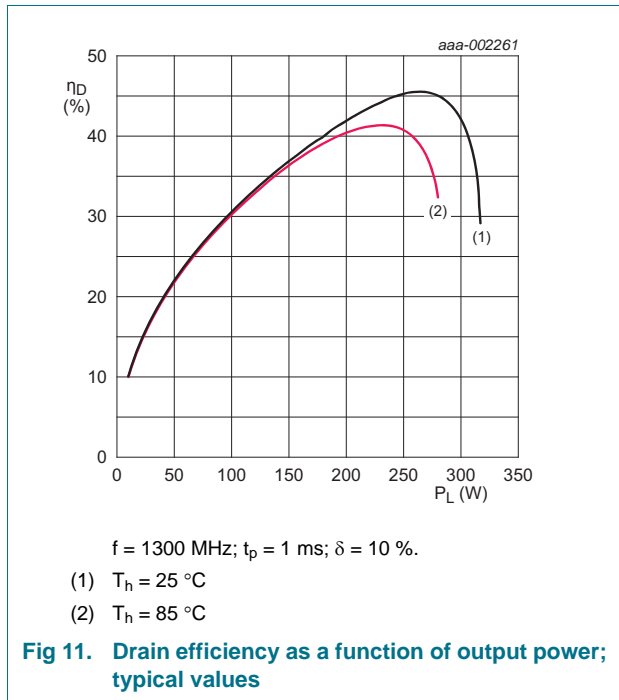
## 7. Application information

### 7.1 Graphs





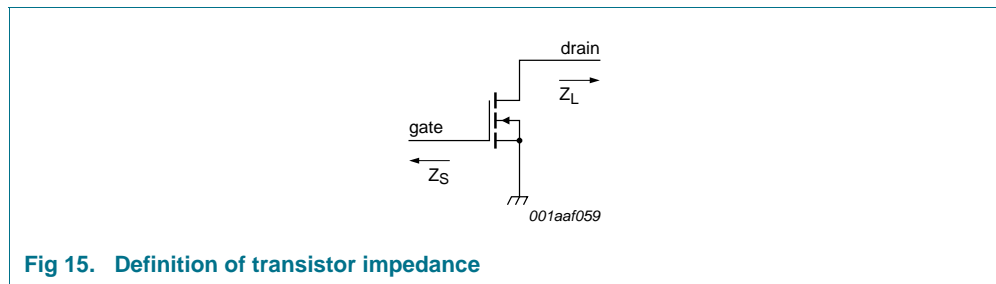




## 7.2 Impedance information

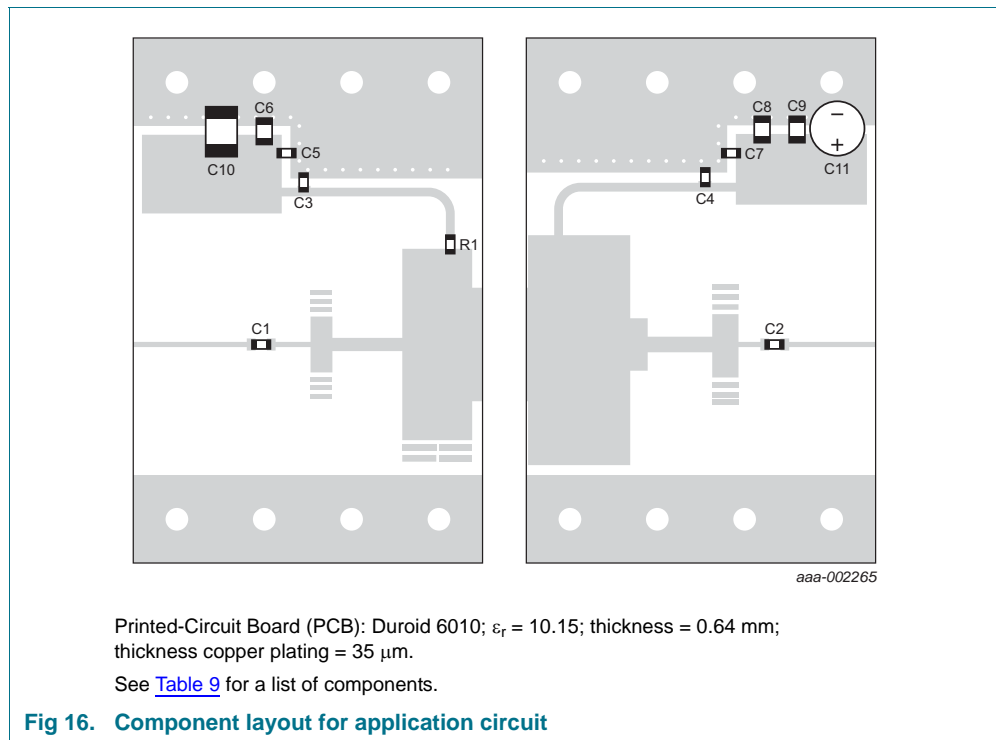
**Table 8. Typical impedance**  
*Typical values unless otherwise specified.*

f GHz	Z <sub>S</sub> Ω	Z <sub>L</sub> Ω
1.2	1.077 – j2.78	1.288 – j1.014
1.3	1.352 – j2.949	1.139 – j1.086
1.4	1.881 – j2.640	1.038 – j1.132



**Fig 15. Definition of transistor impedance**

## 7.3 Circuit information



Printed-Circuit Board (PCB): Duroid 6010;  $\epsilon_r = 10.15$ ; thickness = 0.64 mm;  
 thickness copper plating = 35  $\mu\text{m}$ .

See [Table 9](#) for a list of components.

**Fig 16. Component layout for application circuit**



**Table 9. List of components***For test circuit see [Figure 16](#).*

Component	Description	Value	Remarks
C1, C2, C3, C4, C7	multilayer ceramic chip capacitor	56 pF	[1]
C5, C8	multilayer ceramic chip capacitor	200 pF	[2]
C6, C9	multilayer ceramic chip capacitor	1 nF	[3]
C10	multilayer ceramic chip capacitor	10 $\mu$ F; 20 V	
C11	electrolytic capacitor	22 $\mu$ F; 63 V	
R1	SMD resistor	10 $\Omega$	0603

[1] American Technical Ceramics type 100A or capacitor of same quality.

[2] American Technical Ceramics type 100B or capacitor of same quality.

[3] American Technical Ceramics type 700A or capacitor of same quality.

**8. Package outline**

Flanged LDMOST ceramic package; 2 mounting holes; 2 leads

SOT502A

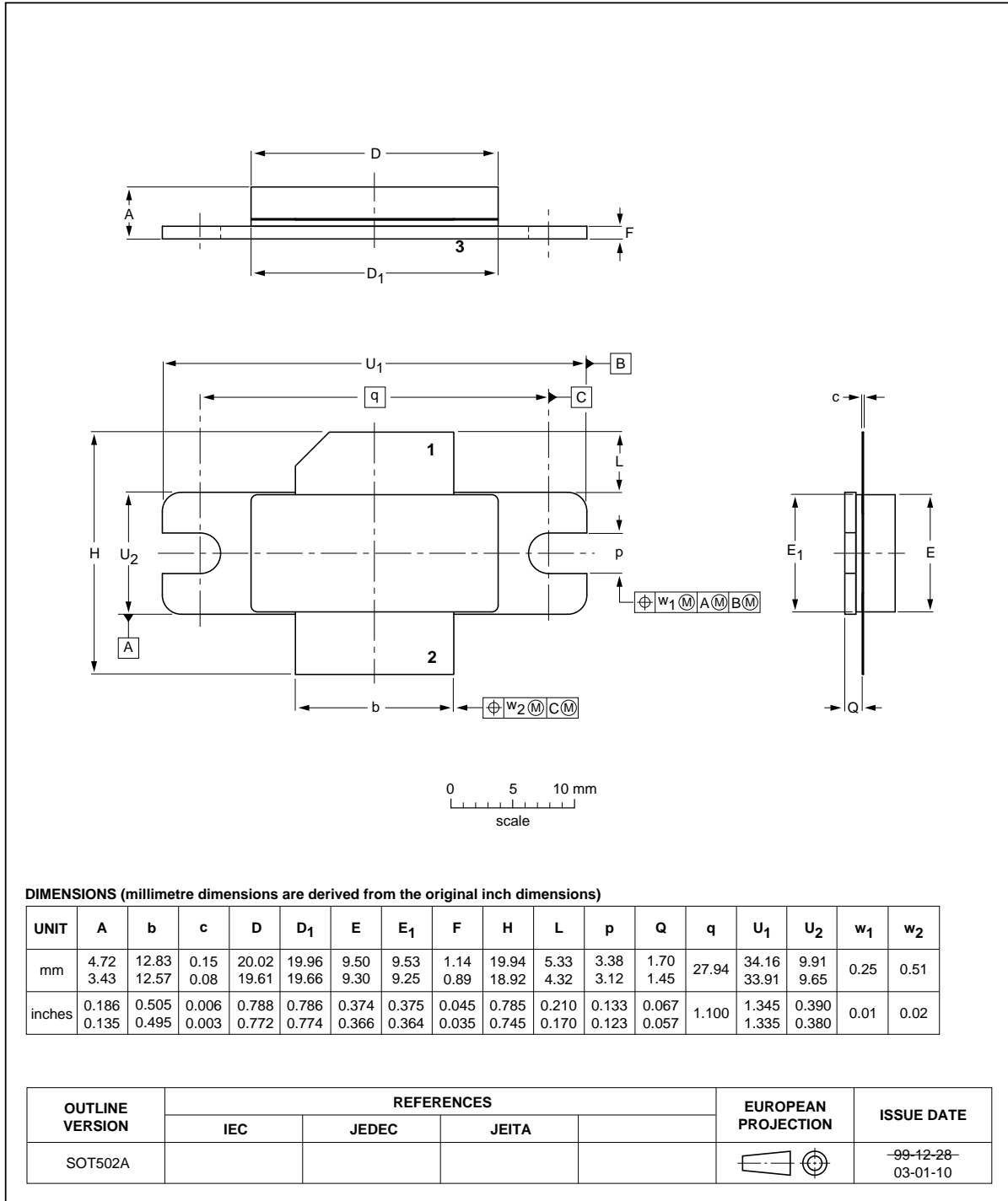


Fig 17. Package outline SOT502A

## 9. Handling information

### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

## 10. Abbreviations

Table 10. Abbreviations

Acronym	Description
DC	Direct Current
ESD	ElectroStatic Discharge
IR	InfraRed
L-band	Long wave band
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
RF	Radio Frequency
SMD	Surface Mounted Device
VSWR	Voltage Standing-Wave Ratio

## 11. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLL6G1214L-250 v.1	20120216	Preliminary data sheet	-	-

## 12. Legal information

### 12.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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